Se	arch Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/604,834	CHEN ET AL.	
Examiner	Art Unit	
Khanh Tran	2611	

	SEAR	CHED	
Class	Subclass	Date	Examiner
375	340,342, 343,260, 222,245	2/1/2007	кст
	364,-365		
370	503,509		
	210,514		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
375	All subclame Stated	2/1/2007	кст
370	ų		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Searches EAST	2/1/2007	кст
Inventor Name Searches		
NPL Searches		
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